

Notice of References Cited	Application/Control No. 10/518,487	Applicant(s)/Patent Under Reexamination TANAKA ET AL.	
	Examiner Sue A. Weaver	Art Unit 3781	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-3,708,082	01-1973	Platte, Richard L.	215/385
*	B	US-6,695,162	02-2004	Boukobza et al.	215/384
*	C	US-6,161,713	12-2000	Krich, Jeffrey D.	215/384
*	D	US-5,224,614	07-1993	Bono et al.	215/384
*	E	US-5,350,078	09-1994	Potts et al.	215/384
*	F	US-3,536,500	10-1970	CLEEREMAN KENNETH J; et. al.	426/130
*	G	US-3,537,498	11-1970	AMAND ELMER F ST	604/403
*	H	US-6,068,161	05-2000	Soehnlén et al.	222/143
*	I	US-2003/0010743	01-2003	Boukobza, Michel	215/382
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 2002145233 A	05-2002	Japan	MIURA, MASAKI	
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.